

**Notice of References Cited**

Application/Control No.

10/574,378

Applicant(s)/Patent Under  
Reexamination  
GEYER ET AL.

Examiner

MIRIAM BERDICHEVSKY

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0179143	12-2002	Haussler et al.	136/265
*	B	US-6,281,427	08-2001	Mitsuhiro et al.	136/250
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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